

Applications

- Military Radar
- Electronic Warfare
- Test Equipment

Product Features

- Frequency Range: 2 to 18 GHz
- P_{SAT}: 40 dBm at V_D = 30 V
- PAE: 20% Typical
- Small Signal Gain: 10 dB
- Return Loss: 15 dB
- Bias: V_D = 30 V, I_{DQ} = 500 mA, V_G = -2.3 V Typical
- Technology: 0.25- μ m GaN on SiC
- Dimensions: 5.66 x 2.67 x 0.5 mm

General Description

The Qorvo TGA2573-2-TS is a wideband, high power GaN HEMT amplifier fabricated on Qorvo's production 0.25- μ m GaN on SiC process. Operating from 2 to 18 GHz, it achieves 40 dBm saturated output power, 20% PAE, and 10 dB small signal gain at a drain bias of 30 V.

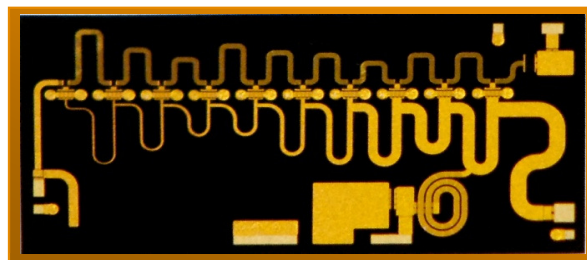
The TGA2573-2-TS is a 4-mil thick GaN die mounted on a 15 mil thick Cu-Mo-Cu carrier. This provides the customer a known good die attach to assist in thermal management and provide easier handling

Fully matched to 50 Ω and with integrated DC blocking caps on both RF ports, the TGA2573-2-TS is ideally suited to support both commercial and defense related applications.

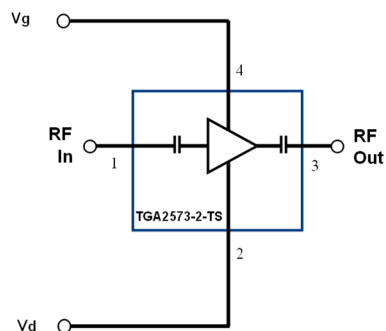
The TGA2573-2-TS is 100% DC and RF tested on-wafer to ensure compliance to performance specifications.

Lead-free and RoHS compliant.

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Functional Block Diagram



Pad Configuration

Pad No.	Symbol
1	RF In
2	V _D
3	RF Out
4	V _G

Ordering Information

Part	ECCN	Description
TGA2573-2-TS	3A611.x	Die on Thermal Spreader

Absolute Maximum Ratings

Parameter	Value
Drain Voltage (V_D) ⁽¹⁾	40 V
Gate Voltage Range (V_G)	-8 to 0 V
Drain-to-Gate Voltage (V_{DG})	80 V
Drain Current (I_D) ^{(1) (2)}	1.3 A
Gate Current (I_G) @ $T = 85$ °C	-4 to 11 mA
Power Dissipation (P_{DISS})	30 W
RF Input Power, CW, 50 Ω , $T = 25$ °C (P_{IN}) ⁽¹⁾	35 dBm
Channel Temperature (T_{CH})	275 °C
Mounting Temperature (30 Seconds)	320 °C
Storage Temperature	-55 to 150 °C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

Parameter	Min	Typ	Max	Units
Drain Voltage (V_D)		30	35	V
Drain Current (I_D)		500		mA
Drain Current Under RF Drive (I_{D_DRIVE}) ⁽¹⁾		1200		mA
Gate Voltage (V_G)		-2.3		V

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

Test conditions unless otherwise noted: 25 °C, $V_D = 30$ V, $I_{DQ} = 500$ mA, $V_G = -2.3$ V Typical

Parameter	Typical	Units
Operational Frequency Range	2 to 18	GHz
Small Signal Gain	10	dB
Input Return Loss	15	dB
Output Return Loss	15	dB
Output Power at Saturation (Input Power = 35 dBm)	40	dBm
Output Power at 30 dBm Input Power	38	dBm
Power Added Efficiency	20	%
Output TOI at $P_{out}/tone = 25$ dBm	45	dBm
Noise Figure	6	dB
Small Signal Gain Temperature Coefficient	-0.02	dB/°C
Output Power Temperature Coefficient	-0.005	dBm/°C

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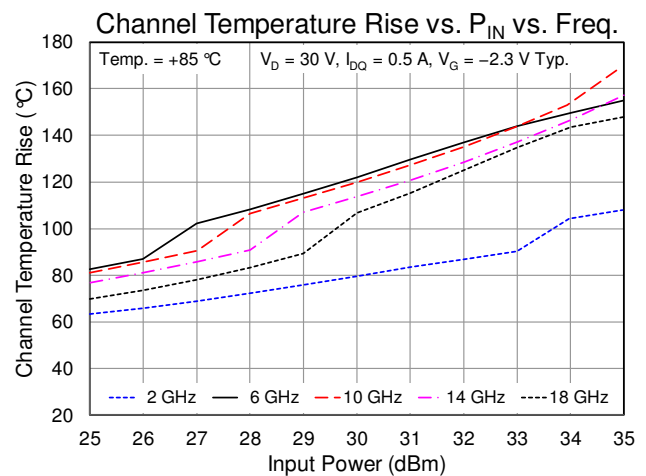
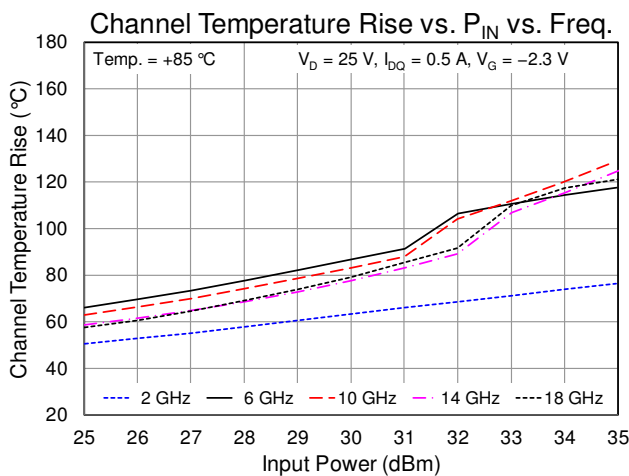
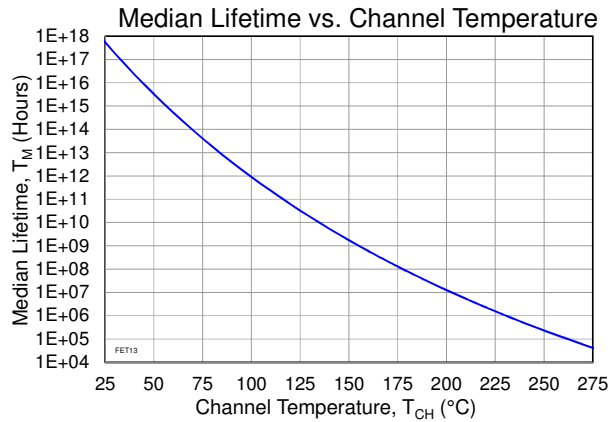
Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC}) ⁽¹⁾	$P_{DISS} < 17\text{ W}$	5.4	$^{\circ}\text{C/W}$
	$17\text{ W} < P_{DISS} < 27\text{ W}$	6.0	$^{\circ}\text{C/W}$
	$P_{DISS} > 27\text{ W}$	6.2	$^{\circ}\text{C/W}$
Channel Temperature (T_{CH})	$V_D = 30\text{ V}$, $I_D = 500\text{ mA}$, $P_{DISS} = 15\text{ W}$, $T_{BASE} = 85\text{ }^{\circ}\text{C}$	166	$^{\circ}\text{C}$
Median Lifetime (T_M)		3.2×10^8	Hrs
Maximum Channel Temperature (T_{CH}), Under RF Drive	See plots below		

Notes:

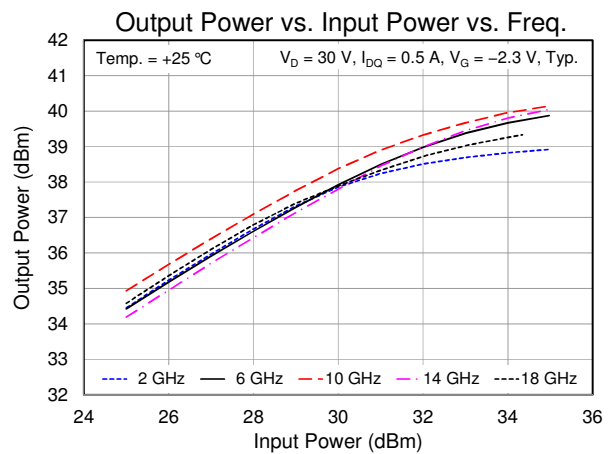
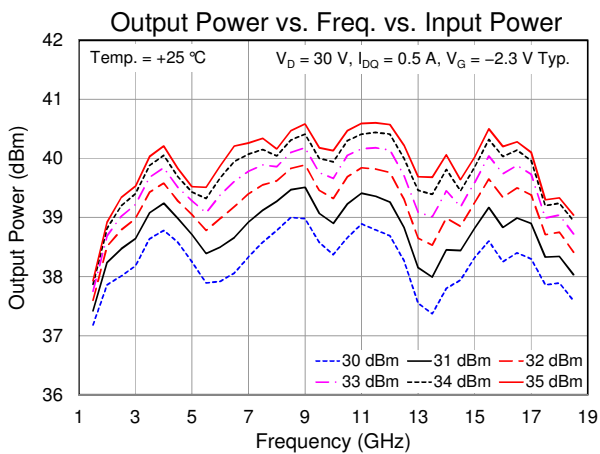
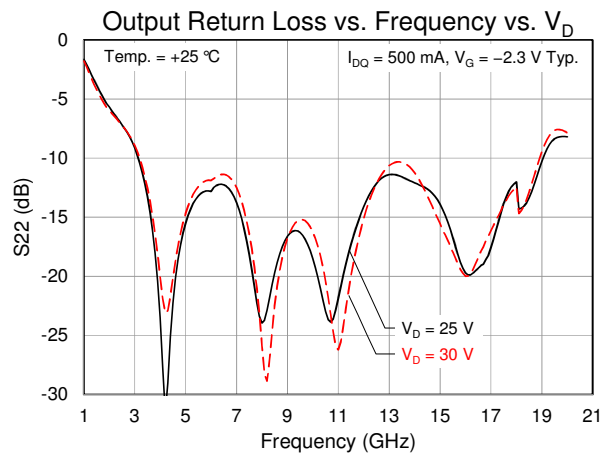
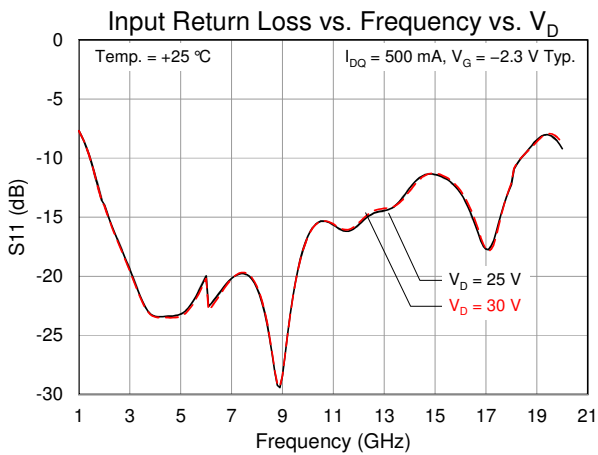
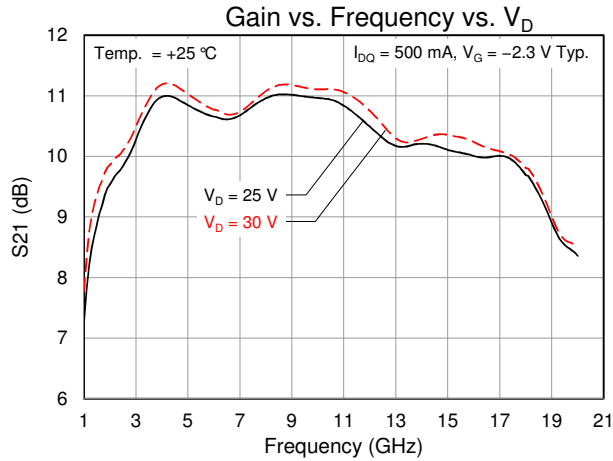
1. Thermal resistance measured to back of carrier.

Median Lifetime and Channel Temperature Rise



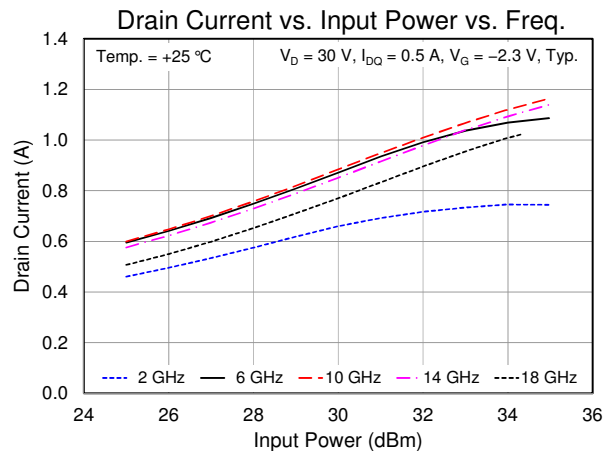
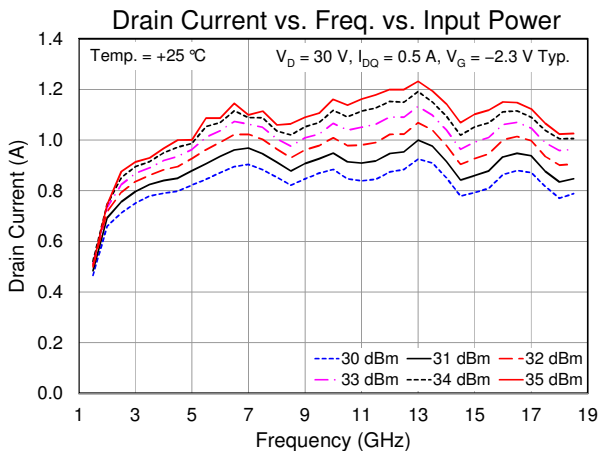
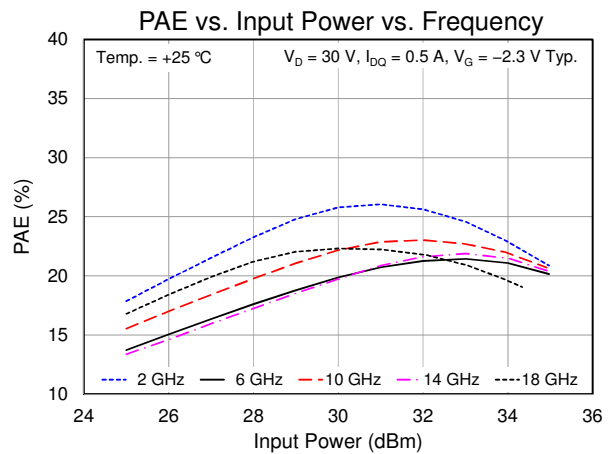
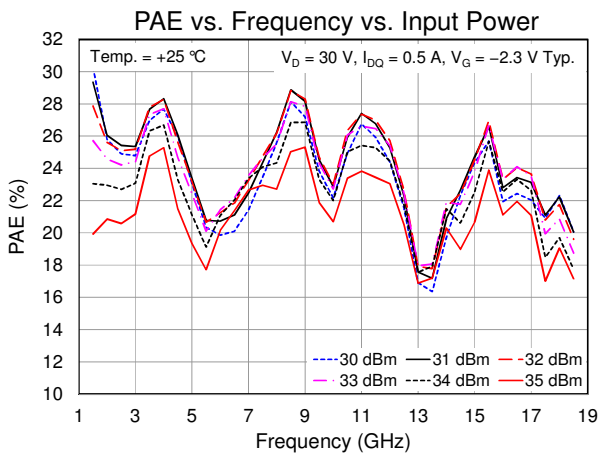
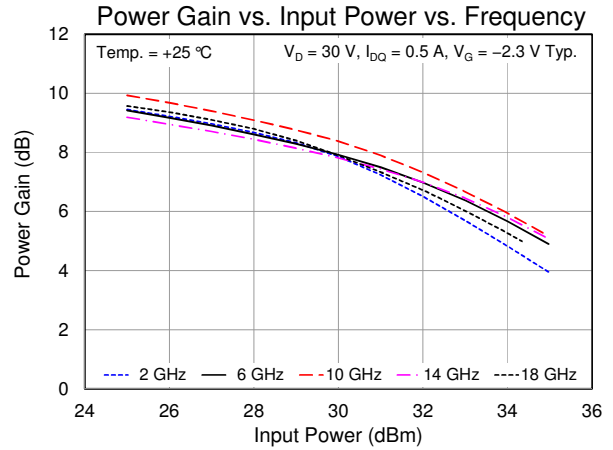
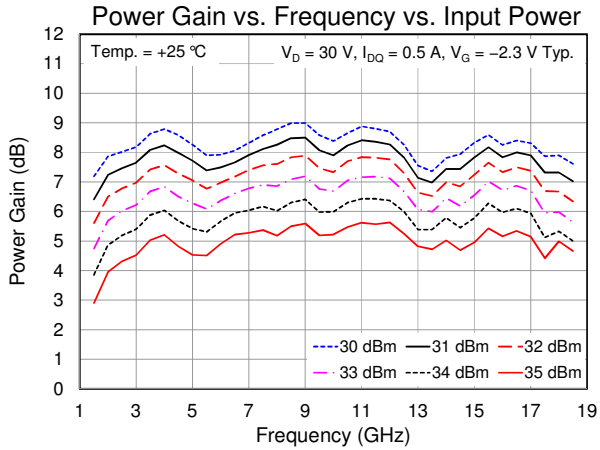
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Typical Performance



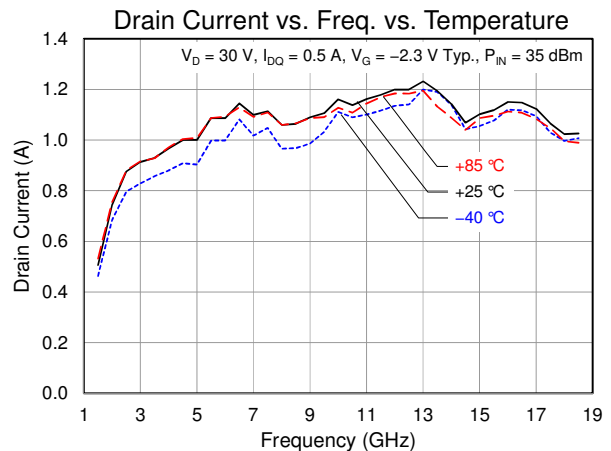
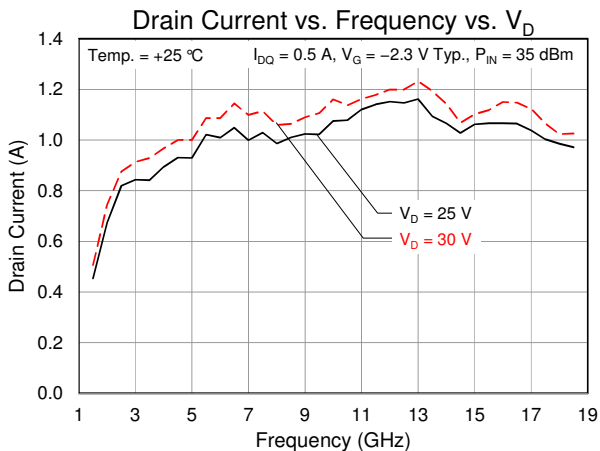
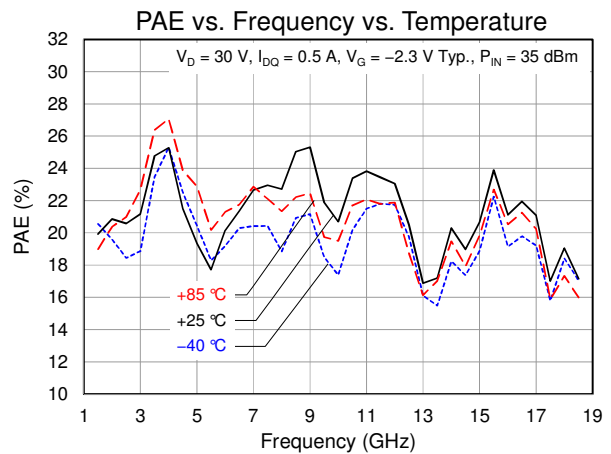
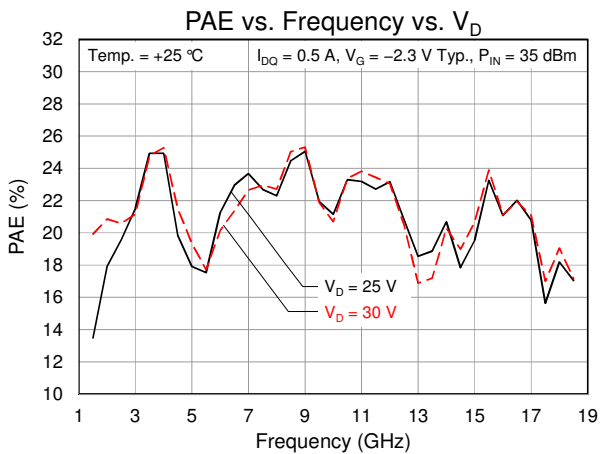
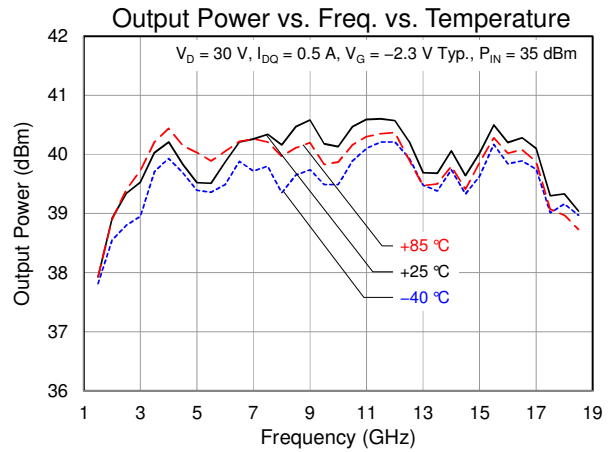
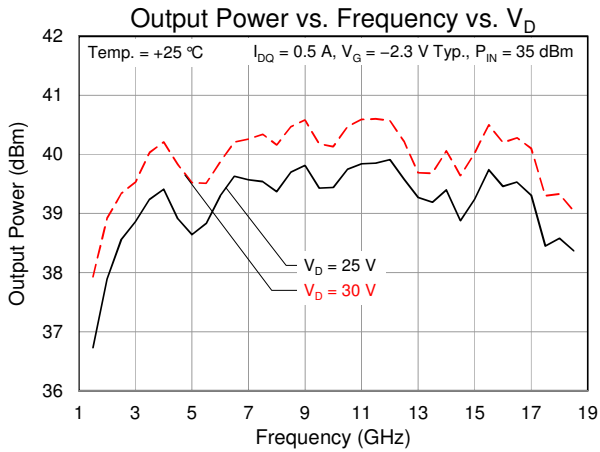
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Typical Performance



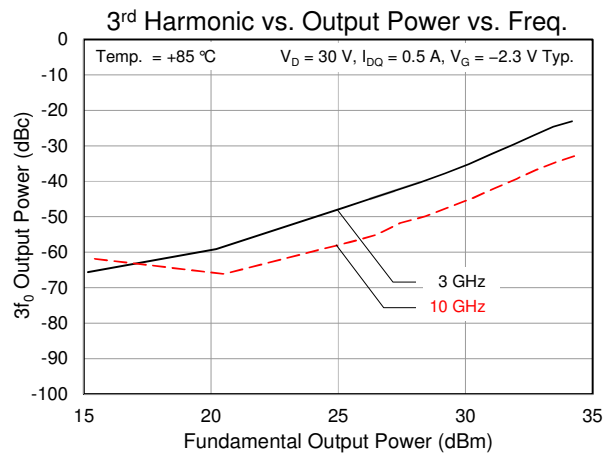
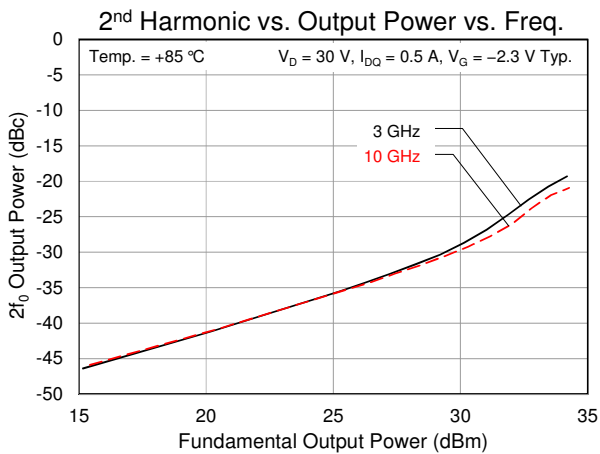
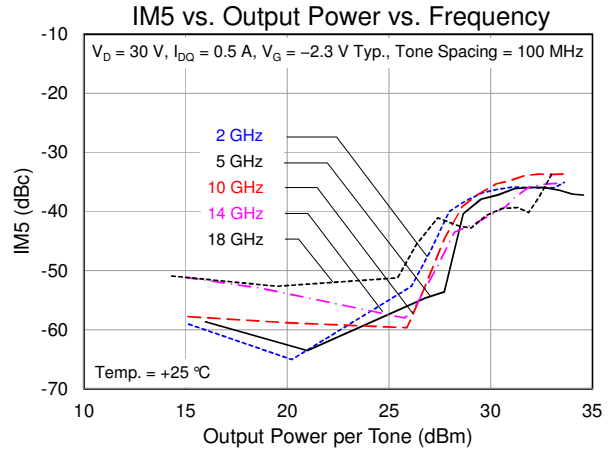
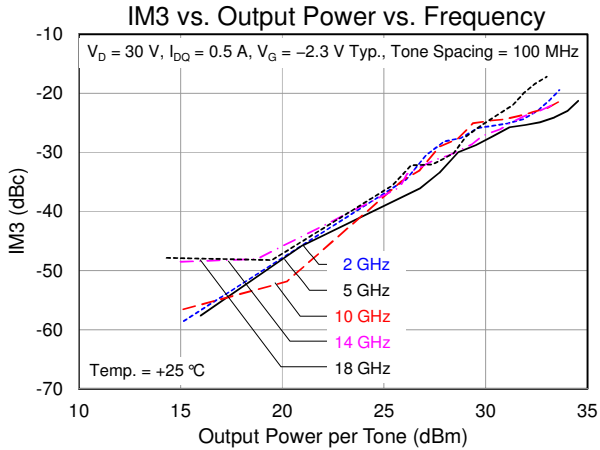
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Typical Performance



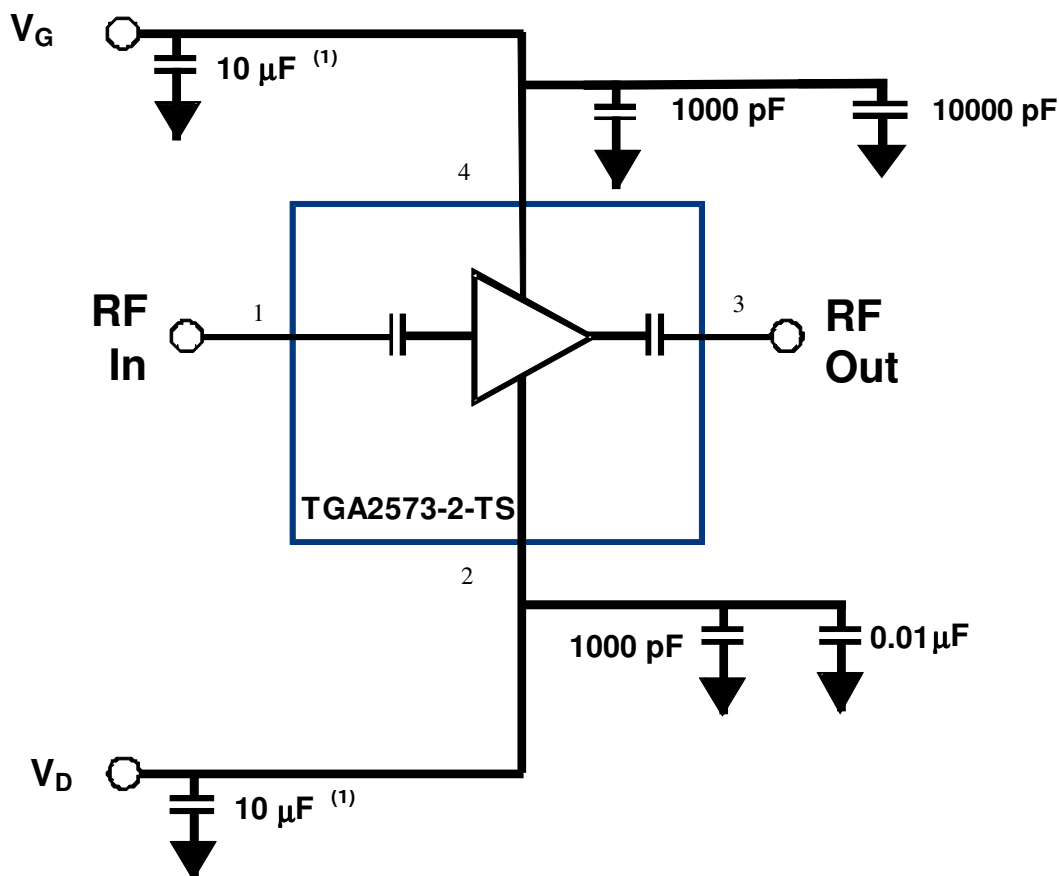
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Typical Performance



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Application Circuit



Notes:

1. Additional bypass capacitors may be required at this location. The value of these capacitors varies by application. Variables include power supply impedance, power supply stability with reactive loads, and the inductance from the power supply to this assembly. One to 47 uF tantalum capacitors are commonly used here.

Bias-up Procedure

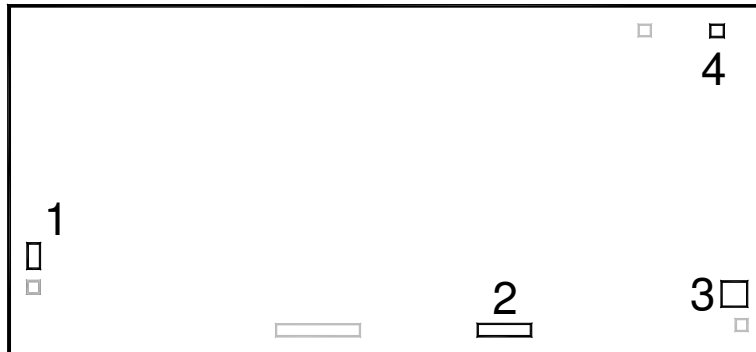
1. Set I_D limit to 1.3 A, I_G limit to 3 mA
2. Apply -5.0 V to V_G
3. Apply +30 V to V_D
4. Adjust V_G more positive until $I_{DQ} = 500$ mA ($V_G \sim -2.3$ V Typical)
5. Apply RF signal

Bias-down Procedure

1. Turn off RF signal
2. Reduce V_G to -5.0 V. Ensure $I_{DQ} \sim 0$ mA
3. Set V_D to 0 V
4. Turn off V_D supply
5. Turn off V_G supply

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Bond Pad Description

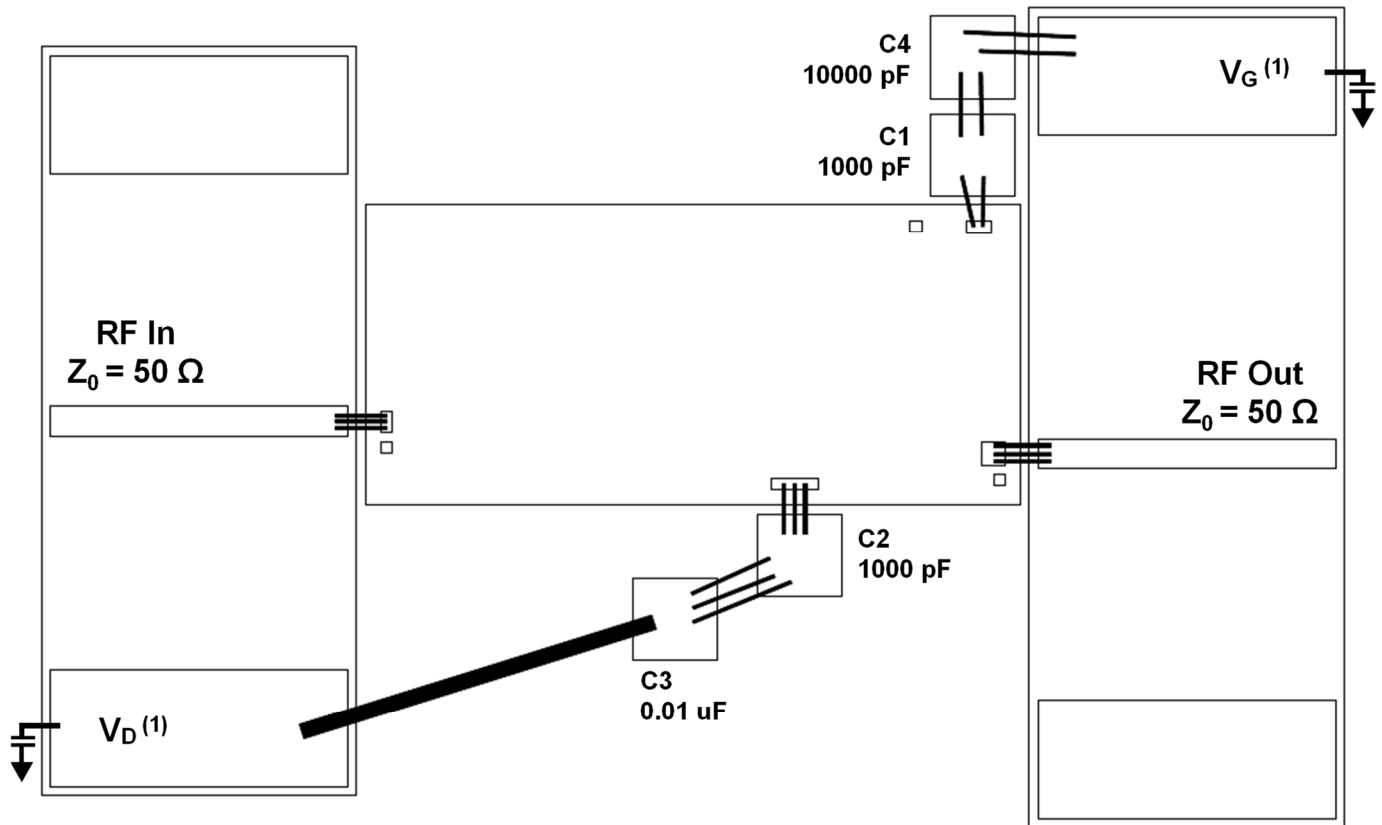


Bond Pads

Pad No.	Symbol	Description
1	RF In	Input; matched to 50 Ω
2	V _D	Drain voltage; bias network is required; see Application Circuit on page 8 as an example
3	RF Out	Output, matched to 50 Ω
4	V _G	Gate voltage; bias network is required; see Application Circuit on page 8 as an example
Backside	GND	Backside of carrier

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Assembly Drawing



Notes:

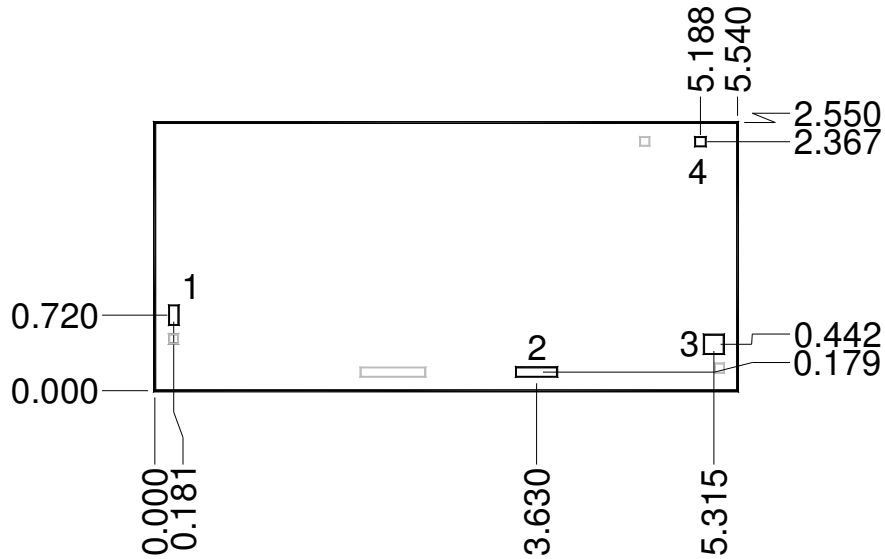
1. See Application Circuit page 8 Note 1

Bill of Material

Ref Des.	Value	Description	Manufacturer	Part Number
C1, C2	1000 pF	Cap, 50 V, 10%, Single Layer	various	
C3	0.01 μF	Cap, 50 V, 10%, SMD	various	
C4	10000 pF	Cap, 50 V, 10%, Single Layer	various	

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Mechanical Information



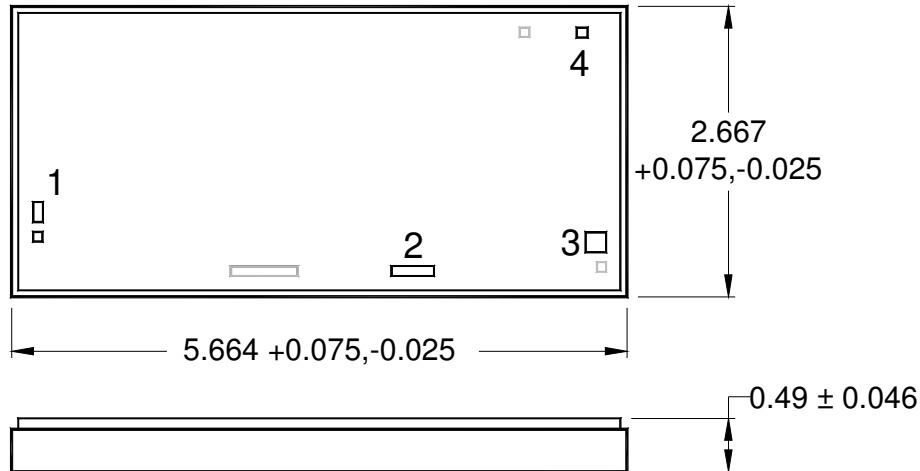
Unit: millimeters
 Thickness: 0.10
 Die x, y size tolerance: ± 0.050
 Chip edge to bond pad dimensions are shown to center of pad
 Ground is backside of die

Bond Pad Dimensions

Pad No.	Symbol	Pad Size
1	RF In	0.100 x 0.195
2	V _D	0.400 x 0.100
3	RF Out	0.200 x 0.195
4	V _G	0.110 x 0.100

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Mechanical Information – Die on Carrier



Unit: millimeters
 Material for carrier:
 Cu-Mo-Cu
 Thickness: 0.381 ± 0.025
 Plating for carrier:
 Gold (Au) over Nickel (Ni)
 MMIC die is attached to carrier using solder
 MMIC die is nominally centered on carrier.

Assembly Notes

Component placement assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonics are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

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Product Compliance Information

ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: TBD
Value: TBD
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

ECCN

US Department of State 3A611.x

RoHS Compliance

This part is compliant with the 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment), as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Contact Information

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- Поставка электронных компонентов под контролем ВП;
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- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

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JONHON

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



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